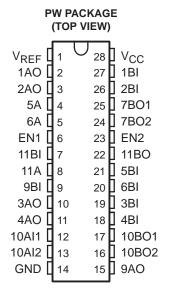
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- Operates as a GTL-/GTL/GTL+ to LVTTL or LVTTL to GTL-/GTL/GTL+ Translator
- Series Termination on TTL Outputs of 30 Ω
- Latch-Up Testing Done to JEDEC Standard JESD 78
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

description/ordering information

The SN74GTL2007 is a 12-bit translator to interface between the 3.3-V LVTTL chip set I/O and the Xeon™ processor GTL-/GTL/GTL+ I/O. The device is designed for platform health management in dual-processor applications.



PIN DESCRIPTION

| PIN NUMBER | SYMBOL | NAME AND FUNCTION |
|---------------------------|------------|--|
| 1 | VREF | GTL reference voltage |
| 2-6, 8, 10-13, 15, 23 | ENn nAn | Data and enable inputs/outputs (LVTTL) |
| 7, 9, 16, 17–22, 24–27 | nBn | Data inputs/outputs (GTL-/GTL/GTL+) |
| 14 | GND | Ground (0 V) |
| 28 | VCC | Positive supply voltage |

ORDERING INFORMATION

| TA | PACKAGE [†] | | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|---------------|----------------------|---------------|--------------------------|---------------------|
| -40°C to 85°C | TSSOP – PW | Tube | SN74GTL2007PW | GK2007 |
| -40 C 10 65 C | 1330F - FW | Tape and reel | SN74GTL2007PWR | GN2007 |

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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Function Tables

| INF | PUTS | OUTPUT |
|-----|---------|---------|
| EN1 | 1BI/2BI | 1AO/2AO |
| Н | L | L |
| Н | Н | Н |
| L | Х | Н |

| INF | PUTS | OUTPUT |
|-----|---------|---------|
| EN2 | 3BI/4BI | 3AO/4AO |
| Н | L | L |
| Н | Н | Н |
| L | X | Н |

| INPUT 9BI | OUTPUT 9AO |
|--------------|---------------|
| L | L |
| Н | Н |

| INPUTS | OUTPUT | |
|-------------|--------|-------------|
| 10AI1/10AI2 | 9BI | 10BO1/10BO2 |
| L | L | L |
| L | Н | L |
| Н | L | L |
| Н | Н | Н |

| INPUTS | | INPUT/OUTPUT 5A/6A | OUTPUT | | |
|--------|---------|-----------------------|----------------|--|--|
| EN2 | 5BI/6BI | (OPEN DRAIN) | 7BO1/7BO2 | | |
| Н | L | L | H [†] | | |
| Н | Н | L‡ | L | | |
| Н | Н | Н | Н | | |
| L | Н | L‡ | L | | |
| L | Н | Н | Н | | |
| L | L | Н | Н | | |
| L | L | L‡ | Н | | |

| INPUT 11BI | INPUT/OUTPUT 11A (OPEN DRAIN) | OUTPUT 11BO |
|---------------|-------------------------------------|----------------|
| L | Н | L |
| L | L‡ | Н |
| Н | L | Н |

H = High voltage level

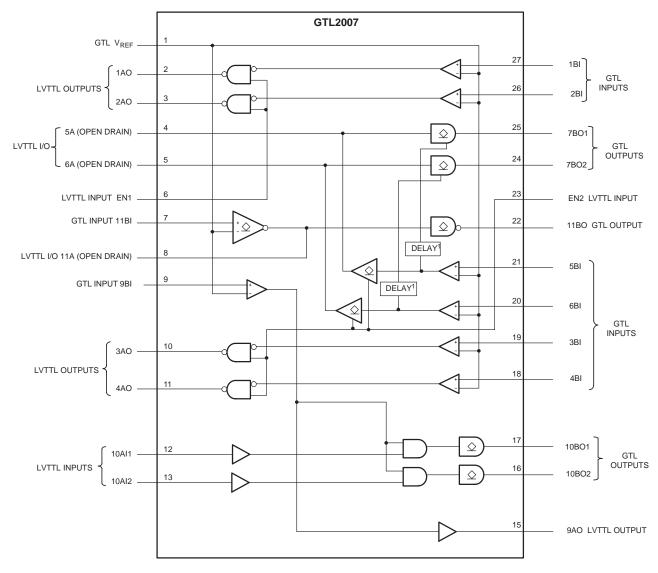
L = Low voltage level

[‡] Open-drain input/output terminal is driven to a logic-low state by an external driver.



[†] The enable on 7BO1/7BO2 includes a delay that prevents a transient condition (where 5BI/6BI goes from low to high, and the low to high on 5A/6A lags up to 100 ns) from causing a low glitch on the 7BO1/7BO2 outputs.

logic symbol



NOTE A: The enable on 7BO1/7BO2 includes a delay that prevents a transient conditon (where 5BI/6BI go from low to high, and the low to high on 5A/6A lags up to 100 ns) from causing a low glitch on the 7BO1/7BO2 outputs.

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†‡

| –0.5 to 4.6 V |
|---------------|
| –0.5 to 4.6 V |
| –50 mA |
| –50 mA |
| 32 mA |
| 30 mA |
| –32 mA |
| 62°C/W |
| –60 to 150°C |
| |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The performance capability of a high-performance integrated circuit, in conjunction with its thermal environment, can create junction temperatures that are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

recommended operating conditions

| | | | MIN | NOM | MAX | UNIT | |
|------------------|--------------------------------------|---------|-------------------------|---------------------|--------------------------|------|--|
| VCC | Supply voltage | | 3 | 3.3 | 3.6 | ٧ | |
| | | GTL- | 0.85 | 0.9 | 0.95 | | |
| VTT | Termination voltage | GTL | 1.14 | 1.2 | 1.26 | V | |
| | | GTL+ | 1.35 | 1.5 | 1.65 | 1 | |
| | Reference voltage | Overall | 0.5 | 2/3 V _{TT} | 1.8 | | |
| V _{REF} | | GTL- | 0.5 | 0.6 | 0.63 |] ,, | |
| | | GTL | 0.76 | 0.8 | 0.84 | V | |
| | | GTL+ | 0.87 | 1 | 1.1 | 1 | |
| | Input voltage | A port | 0 | 3.3 | 3.6 | | |
| VI | | B port | 0 | VTT | 3.6 | V | |
| | | A port | 2 | | | | |
| V_{IH} | HIGH-level input voltage | B port | V _{REF} + 50 m | V | | V | |
| | | A port | | | 0.8 | | |
| V_{IL} | LOW-level input voltage | B port | | | V _{REF} - 50 mV | ٧ | |
| loh | HIGH-level output current | A port | | | -16 | mA | |
| lOL | | A port | | | 16 | | |
| | LOW-level output current | B port | | | 15 | mA | |
| TA | Operating free-air temperature range | • | -40 | | 85 | °C | |



[‡] Voltages are referenced to GND (ground = 0 V).

^{2.} The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

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electrical characteristics over recommended operating conditions

| PARAMETER | | TEST CONDITIONS | –40°C | | | |
|-------------------|--------------------------|---|-----------------------|------------------|-----|------|
| | PARAMETER | TEST CONDITIONS | MIN | TYP [†] | MAX | UNIT |
| \ \ + | Anad | $V_{CC} = 3 \text{ V to } 3.6 \text{ V, } I_{OH} = -100 \mu\text{A}$ | V _{CC} - 0.2 | | | ., |
| V _{OH} ‡ | A port | $V_{CC} = 3 \text{ V, } I_{OH} = -16 \text{ mA}$ | 2.1 | | | V |
| + | A port | V _{CC} = 3 V, I _{OL} = 16 mA | | | 8.0 | ., |
| V _{OL} ‡ | B port | V _{CC} = 3 V, I _{OL} = 15 mA | | | 0.4 | V |
| | Anad | $V_{CC} = 3.6 \text{ V}, V_I = V_{CC}$ | | | ±1 | |
| Ц | A port | V _{CC} = 3.6, V _I = 0 V | | | ±1 | μΑ |
| | B port | $V_{CC} = 3.6 \text{ V}, V_I = V_{TT} \text{ or GND}$ | | | ±1 | |
| ICC | A or B port | $V_{CC} = 3.6 \text{ V}, V_{I} = V_{CC} \text{ or GND, } I_{O} = 0$ | | | 12 | mA |
| Δlcc§ | A port or control inputs | $V_{CC} = 3.6 \text{ V}, V_{I} = V_{CC} - 0.6 \text{ V}$ | | | 500 | μΑ |
| Con | A port | V _O = 3 V or 0 | | 5 | | |
| CIO | B port | $V_O = V_{TT}$ or 0 | | 4 | | pF |

 $[\]overline{\dagger}$ All typical values are measured at $V_{CC} = 3.3 \text{ V}$ and $T_A = 25^{\circ}\text{C}$.

switching characteristics over recommended operating free-air temperature range

| PARAMETER | | | | GTL- | | | GTL | | | GTL+ | | |
|------------------|------------------|----------|------|---|-----|---|------|---|-----|------|------|----|
| | | WAVEFORM | | V _{CC} = 3.3 V ± 0.3 V V _{REF} = 0.6 V | | $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ $V_{REF} = 0.8 \text{ V}$ | | V _{CC} = 3.3 V ± 0.3 V V _{REF} = 1 V | | | UNIT | |
| | | | MIN | TYP† | MAX | MIN | TYP† | MAX | MIN | TYP† | MAX | |
| tPLH | An to Dn | 4 | 2 | 4 | 8 | 2 | 4 | 8 | 2 | 4 | 8 | 20 |
| tPHL | An to Bn | 1 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | ns |
| tPLH | Do to An | 0 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | |
| tPHL | Bn to An | 2 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | 2 | 5.5 | 10 | ns |
| ^t PLH | 0DI to 40DO: | 2 | 2 | 6 | 11 | 2 | 6 | 11 | 2 | 6 | 11 | |
| t _{PHL} | 9BI to 10BOn | 3 | 2 | 6 | 11 | 2 | 6 | 11 | 2 | 6 | 11 | ns |
| ^t PLH | 4400 - 4400 | | 2 | 8 | 13 | 2 | 8 | 13 | 2 | 8 | 13 | |
| tPHL¶ | 11BI to 11BO | 3 | 2 | 14 | 21 | 2 | 14 | 21 | 2 | 14 | 21 | ns |
| ^t PLH | Do to Do | 2 | 4 | 7 | 11 | 4 | 7 | 11 | 4 | 7 | 11 | 20 |
| tPHL | Bn to Bn | 3 | 120 | 205 | 350 | 120 | 205 | 350 | 120 | 205 | 350 | ns |
| tPLH | ENIO AO AO | 4 | 1 | 3 | 7 | 1 | 3 | 7 | 1 | 3 | 7 | |
| t _{PHL} | ENn to An | 4 | 1 | 3 | 7 | 1 | 3 | 7 | 1 | 3 | 7 | ns |
| t _{PLZ} | D. (2. A.: (1/O) | - | 2 | 5 | 10 | 2 | 5 | 10 | 2 | 5 | 10 | |
| tPZL | Bn to An (I/O) | 5 | 2 | 5 | 10 | 2 | 5 | 10 | 2 | 5 | 10 | ns |
| tPLZ | EN2 to An (I/O) | 6 | 1 | 3 | 7 | 1 | 3 | 7 | 1 | 3 | 7 | no |
| tPZL | EN2 to An (I/O) | 6 | 1 | 3 | 7 | 1 | 3 | 7 | 1 | 3 | 7 | ns |
| + | | | 0500 | | | | | | _ | | _ | |

[†] All typical values are measured at $V_{CC} = 3.3 \text{ V}$ and $T_A = 25^{\circ}\text{C}$.

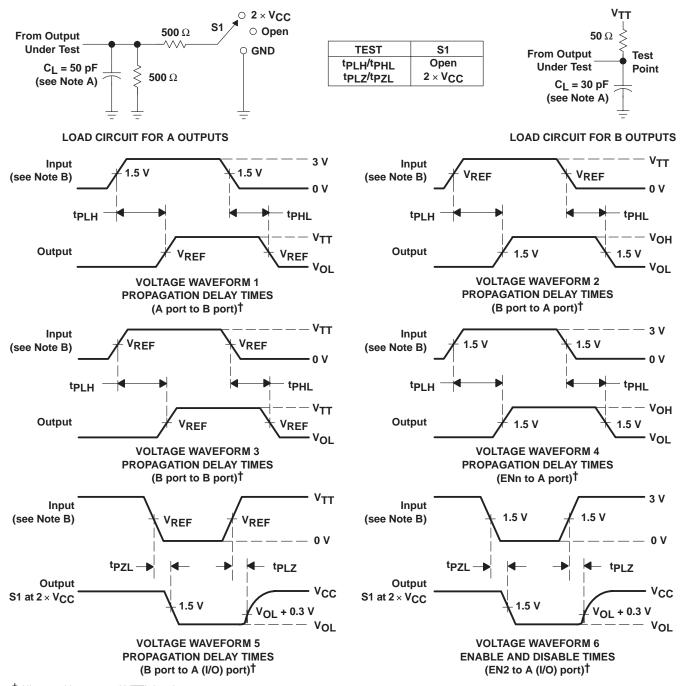


[‡] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[§] This is the increase in supply current for each input that is at the specified LVTTL voltage, rather than V_{CC} or GND.

[¶] Includes ~7.6-ns RC rise time of test-load pullup on 11-A, 1.5-kΩ pullup, and 21-pF load on 11 A has approximately 23-ns RC rise time.

PARAMETER MEASUREMENT INFORMATION V_{TT} = 1.2 V, V_{REF} = 0.8 V FOR GTL AND V_{TT} = 1.5 V, V_{REF} = 1 V FOR GTL+



† All control inputs are LVTTL levels.

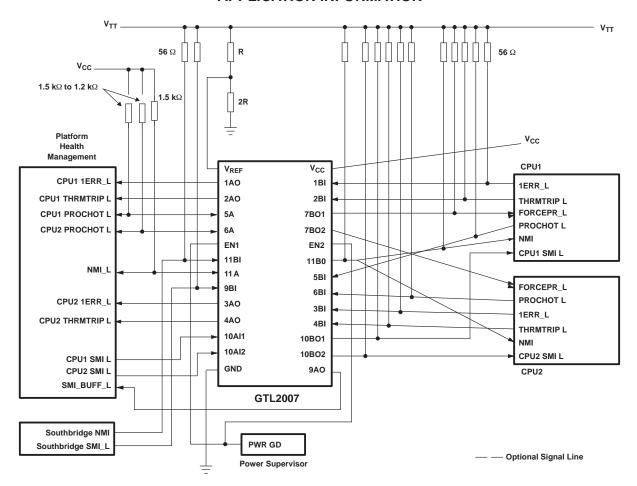
NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- C. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



APPLICATION INFORMATION



Frequently Asked Questions

Question 1: On the GTL2007 LVTTL input, specifically 10Al1 and 10Al2, when the GTL2007 is powered down, these inputs may be pulled up to 3.3 V, and we want to ensure that there is no leakage path to the power rail under this condition. Are the LVTTL inputs high impedance when the device is powered down, and will there be any leakage?

Answer 1: When the device is powered down, the LVTTL inputs are in a high-impedance state and do not leak to V_{DD} if they are pulled high while the device is powered down.

Question 2: Do all the LVTTL inputs have the same powered-down characteristic?

Answer 2: Yes

Question 3: What is the condition of the other GTL I/O and LVTTL output pins when the device is powered down?

Answer 3: The open-drain outputs, both GTL and LVTTL, do not leak to the power supply if they are pulled high while the device is powered down. The GTL inputs also do not leak to the power supply under the same conditions. The LVTTL totem-pole outputs, however, are not open-drain type outputs, and there is no current flow on these pins if they are pulled high when V_{DD} is at ground.







www.ti.com 24-Jan-2013

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Top-Side Markings | Samples |
|------------------|--------|--------------|--------------------|------|-------------|----------------------------|------------------|--------------------|--------------|-------------------|---------|
| SN74GTL2007PW | ACTIVE | TSSOP | PW | 28 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |
| SN74GTL2007PWE4 | ACTIVE | TSSOP | PW | 28 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |
| SN74GTL2007PWG4 | ACTIVE | TSSOP | PW | 28 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |
| SN74GTL2007PWR | ACTIVE | TSSOP | PW | 28 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |
| SN74GTL2007PWRE4 | ACTIVE | TSSOP | PW | 28 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |
| SN74GTL2007PWRG4 | ACTIVE | TSSOP | PW | 28 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 85 | GK2007 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.



PACKAGE OPTION ADDENDUM

24-Jan-2013

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

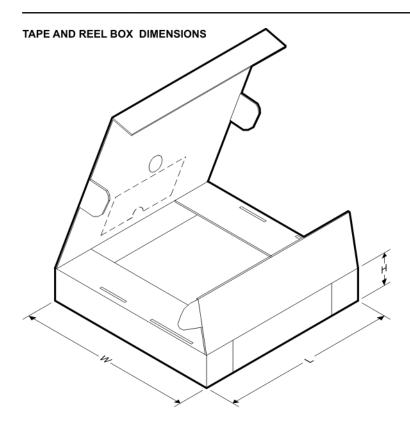


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74GTL2007PWR | TSSOP | PW | 28 | 2000 | 330.0 | 16.4 | 6.9 | 10.2 | 1.8 | 12.0 | 16.0 | Q1 |

PACKAGE MATERIALS INFORMATION

www.ti.com 5-Feb-2013

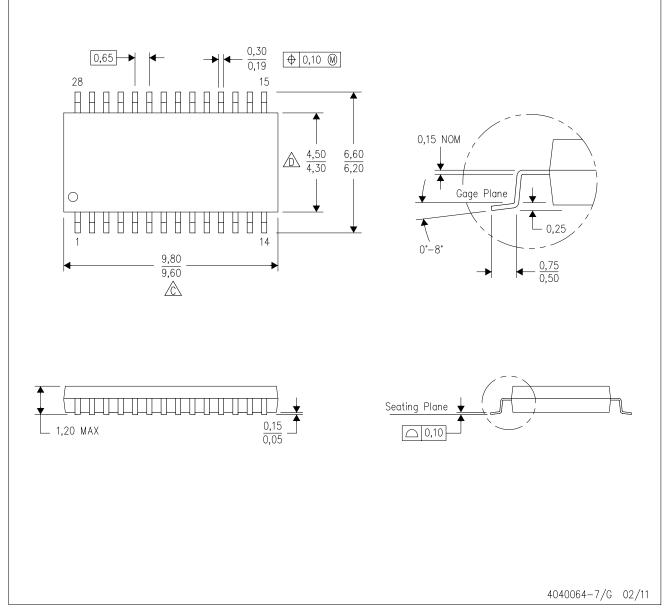


*All dimensions are nominal

| Device Package T | | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) | |
|------------------|-------|-----------------|------|------|-------------|------------|-------------|--|
| SN74GTL2007PWR | TSSOP | PW | 28 | 2000 | 367.0 | 367.0 | 38.0 | |

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



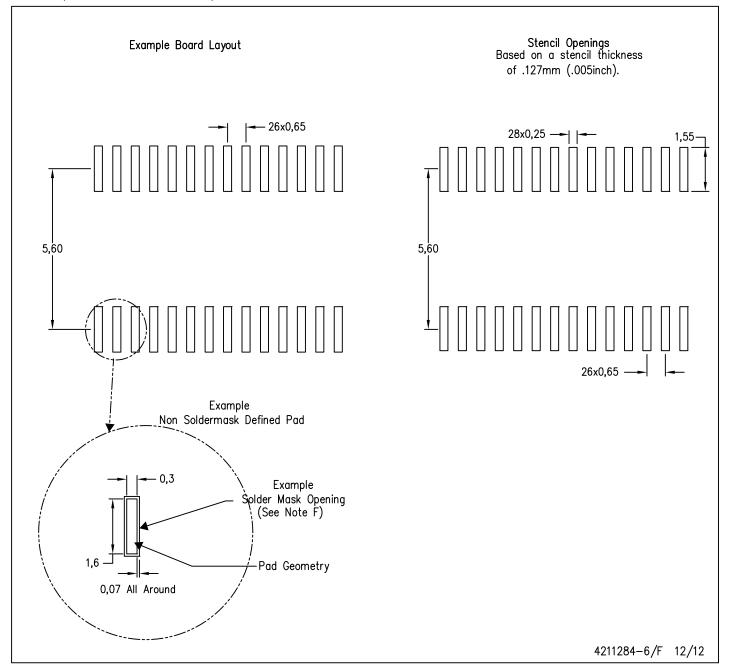
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



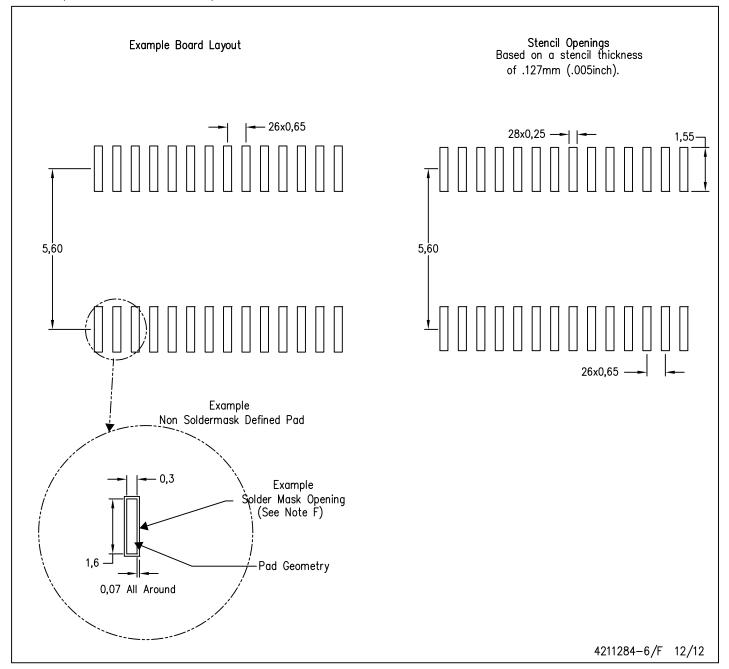
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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